Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | DEPKE ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-----|---|-----------------|---------------------|----------------|
| | Α | US-6,526,036 | 02-2003 | Ųchida et al. | 370/342 |
| | В | US-2003/0046238 | 03-2003 | Nonaka et al. | 705/51 |
| | С | US-6,912,200 | 06-2005 | Halme, Matti | 370/238 |
| , | D | US-2005/0049971 | 03-2005 | Bettinger, David S. | 705/051 |
| | · E | US-2002/0027907 | 03-2002 | Tateoka, Masamichi | 370/389 |
| | F | US-4,581,656 | 04-1986 | Wada, Yoshinori | 358/437 |
| | G | US-5,699,177 | 12-1997 | Yamamoto, Mitsuru | 398/58 |
| | Н | US-6,072,599 | 06-2000 | Oba et al. | 358/444 |
| | 1 | US-5,257,404 | 10-1993 | Goreham et al. | 455/503 |
| | J | US-4,823,376 | 04-1989 | Takahashi, Shuichi | 379/100.04 |
| | Κ. | US-6,266,162 | 07-2001 | Okamura et al. | 358/468 |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|---|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | • | | | | |
| | S | | | • | | |
| | Ŧ | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|----------|---|
| | υ | |
| | v | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707:05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.